

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/689,480	<b>Applicant(s)/Patent under Reexamination</b> ANJANAPPA ET AL.
<b>Examiner</b> Dinh Q. Nguyen	<b>Art Unit</b> 3752	

SEARCHED			
Class	Subclass	Date	Examiner
239	102.1		
	583.1-		
	585.5		
	533.2		
	583		
	584	11/30/05	WD
251	129.15		
	129.21		
	129.06	11/30/05	WD
137	82	11/30/05	WD

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner